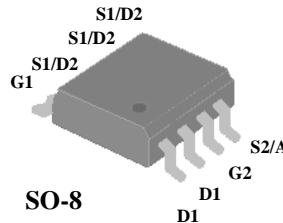




- ▼ Simple Drive Requirement
- ▼ DC-DC Converter Suitable
- ▼ Fast Switching Performance

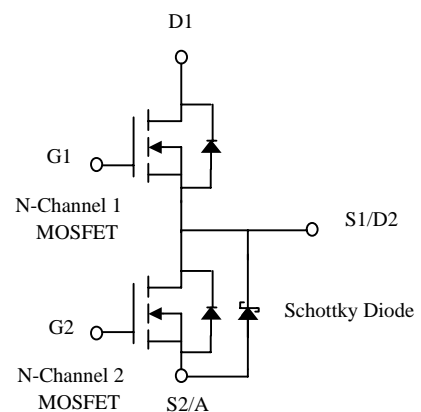


CH-1	BV_{DSS}	30V
	$R_{DS(ON)}$	30m Ω
	I_D	5.7A
CH-2	BV_{DSS}	30V
	$R_{DS(ON)}$	22m Ω
	I_D	9.8A

Description

The Advanced Power MOSFETs from APEC provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The SO-8 package is universally preferred for all commercial-industrial surface mount applications and suited for low voltage applications such as DC/DC converters.



Absolute Maximum Ratings

Symbol	Parameter	Rating		Units
		Channel-1	Channel-2	
V_{DS}	Drain-Source Voltage	30	30	V
V_{GS}	Gate-Source Voltage	± 20	± 20	V
$I_D@T_A=25^\circ C$	Continuous Drain Current ³	5.7	9.8	A
$I_D@T_A=70^\circ C$	Continuous Drain Current ³	4.6	7.8	A
I_{DM}	Pulsed Drain Current ¹	20	30	A
$P_D@T_A=25^\circ C$	Total Power Dissipation	1.4	2.2	W
	Linear Derating Factor	0.01	0.02	W/ $^\circ C$
T_{STG}	Storage Temperature Range	-55 to 150		$^\circ C$
T_J	Operating Junction Temperature Range	-55 to 150		$^\circ C$

Thermal Data

Symbol	Parameter	Value		Units
		Typ.	Max.	
Rthj-a (CH-1)	Thermal Resistance Junction-ambient ³	70	90	$^\circ C/W$
Rthj-a (CH-2)	Thermal Resistance Junction-ambient ³	42	55	$^\circ C/W$



CH-1 Electrical Characteristics @ $T_j=25^{\circ}\text{C}$ (unless otherwise specified)

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Units
BV_{DSS}	Drain-Source Breakdown Voltage	$V_{GS}=0V, I_D=250\mu A$	30	-	-	V
$\Delta BV_{DSS}/\Delta T_j$	Breakdown Voltage Temperature Coefficient	Reference to $25^{\circ}\text{C}, I_D=1\text{mA}$	-	0.01	-	$V/^{\circ}\text{C}$
$R_{DS(ON)}$	Static Drain-Source On-Resistance ²	$V_{GS}=10V, I_D=5A$	-	-	30	$m\Omega$
		$V_{GS}=4.5V, I_D=3A$	-	-	37	$m\Omega$
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_D=250\mu A$	1	-	3	V
g_{fs}	Forward Transconductance	$V_{DS}=10V, I_D=5A$	-	5.7	-	S
I_{DSS}	Drain-Source Leakage Current ($T_j=25^{\circ}\text{C}$)	$V_{DS}=30V, V_{GS}=0V$	-	-	1	μA
	Drain-Source Leakage Current ($T_j=70^{\circ}\text{C}$)	$V_{DS}=24V, V_{GS}=0V$	-	-	25	μA
I_{GSS}	Gate-Source Leakage	$V_{GS}=\pm 20V$	-	-	± 100	nA
Q_g	Total Gate Charge ²	$I_D=6A$	-	9	15	nC
Q_{gs}	Gate-Source Charge	$V_{DS}=24V$	-	2	-	nC
Q_{gd}	Gate-Drain ("Miller") Charge	$V_{GS}=4.5V$	-	6	-	nC
$t_{d(on)}$	Turn-on Delay Time ²	$V_{DS}=15V$	-	8	-	ns
t_r	Rise Time	$I_D=1A$	-	7	-	ns
$t_{d(off)}$	Turn-off Delay Time	$R_G=3.3\Omega, V_{GS}=10V$	-	19	-	ns
t_f	Fall Time	$R_D=15\Omega$	-	6	-	ns
C_{iss}	Input Capacitance	$V_{GS}=0V$	-	610	970	pF
C_{oss}	Output Capacitance	$V_{DS}=25V$	-	160	-	pF
C_{rss}	Reverse Transfer Capacitance	$f=1.0\text{MHz}$	-	120	-	pF
R_g	Gate Resistance	$f=1.0\text{MHz}$	-	1.6	-	Ω

Source-Drain Diode

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Units
V_{SD}	Forward On Voltage ²	$I_S=1.2A, V_{GS}=0V$	-	-	1.2	V
t_{rr}	Reverse Recovery Time ²	$I_S=6A, V_{GS}=0V$	-	18	-	ns
Q_{rr}	Reverse Recovery Charge	$dI/dt=100A/\mu s$	-	11	-	nC



CH-2 Electrical Characteristics @T_j=25°C(unless otherwise specified)

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Units
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V, I _D =250uA	30	-	-	V
ΔBV _{DSS} /ΔT _j	Breakdown Voltage Temperature Coefficient	Reference to 25°C, I _D =1mA	-	0.1	-	V/°C
R _{DS(ON)}	Static Drain-Source On-Resistance ²	V _{GS} =10V, I _D =9A	-	-	22	mΩ
		V _{GS} =4.5V, I _D =7A	-	-	29	mΩ
V _{GS(th)}	Gate Threshold Voltage	V _{DS} =V _{GS} , I _D =250uA	1	-	3	V
g _{fs}	Forward Transconductance	V _{DS} =10V, I _D =9A	-	11	-	S
I _{DSS}	Drain-Source Leakage Current (T _j =25°C)	V _{DS} =30V, V _{GS} =0V	-	-	100	uA
	Drain-Source Leakage Current (T _j =70°C)	V _{DS} =24V, V _{GS} =0V	-	-	1	mA
I _{GSS}	Gate-Source Leakage	V _{GS} =±20V	-	-	±100	nA
Q _g	Total Gate Charge ²	I _D =7A	-	25	40	nC
Q _{gs}	Gate-Source Charge	V _{DS} =24V	-	4	-	nC
Q _{gd}	Gate-Drain ("Miller") Charge	V _{GS} =10V	-	7	-	nC
t _{d(on)}	Turn-on Delay Time ²	V _{DS} =20V	-	10	-	ns
t _r	Rise Time	I _D =1A	-	6	-	ns
t _{d(off)}	Turn-off Delay Time	R _G =5.7Ω, V _{GS} =10V	-	26	-	ns
t _f	Fall Time	R _D =20Ω	-	12	-	ns
C _{iss}	Input Capacitance	V _{GS} =0V	-	1170	1860	pF
C _{oss}	Output Capacitance	V _{DS} =25V	-	205	-	pF
C _{rss}	Reverse Transfer Capacitance	f=1.0MHz	-	142	-	pF
R _g	Gate Resistance	f=1.0MHz	-	1.7	-	Ω

Source-Drain Diode

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Units
V _{SD}	Forward On Voltage ²	I _S =2.6A, V _{GS} =0V	-	-	1.2	V
t _{rr}	Reverse Recovery Time ²	I _S =7A, V _{GS} =0V,	-	21	-	ns
Q _{rr}	Reverse Recovery Charge	dI/dt=100A/μs	-	16	-	nC

Notes:

- 1.Pulse width limited by Max. junction temperature.
- 2.Pulse width ≤300us , duty cycle ≤2%.
- 3.Surface mounted on 1 in² copper pad of FR4 board, t ≤10 sec.

**Schottky Specifications @ $T_j=25^{\circ}\text{C}$ (unless otherwise specified)**

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Units
V_F	Forward Voltage Drop	$I_F=1.0\text{A}$	-	0.47	0.5	V
I_{rm}	Maximum Reverse Leakage Current	$V_r=30\text{V}$	-	0.004	0.2	mA
	Maximum Reverse Leakage Current	$V_r=30\text{V}, T_j=100^{\circ}\text{C}$	-	0.5	1	mA
C_T	Junction Capacitance	$V_r=10\text{V}$	-	66	-	pF



Channel-1

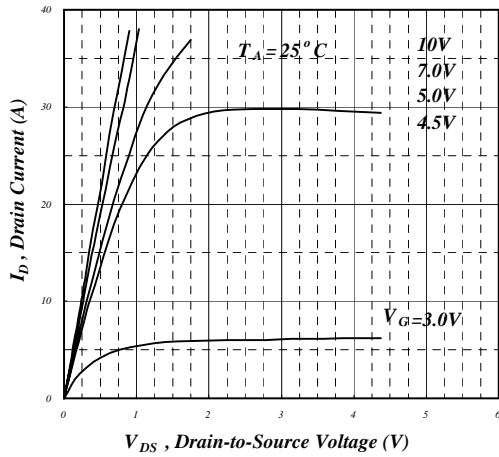


Fig 1. Typical Output Characteristics

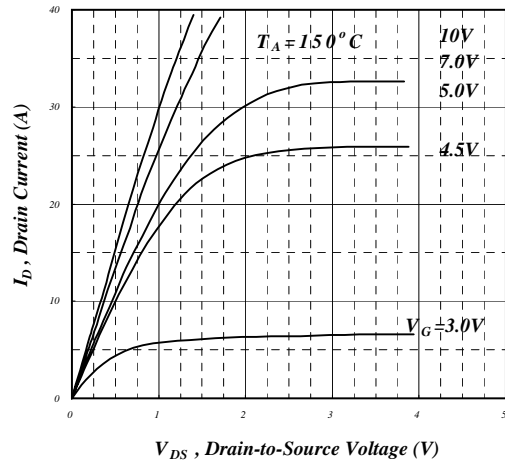


Fig 2. Typical Output Characteristics

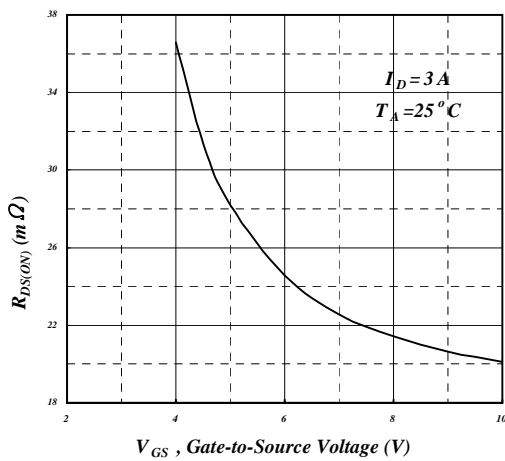


Fig 3. On-Resistance v.s. Gate Voltage

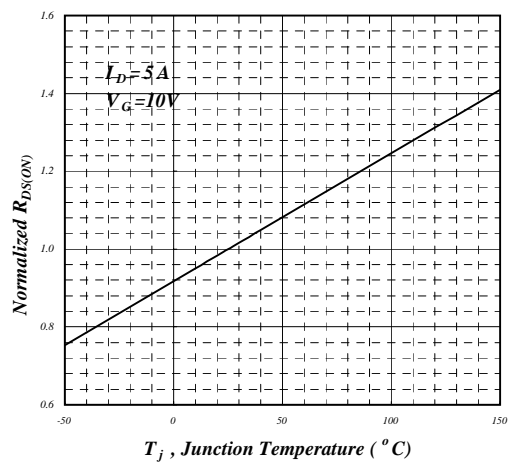


Fig 4. Normalized On-Resistance v.s. Junction Temperature

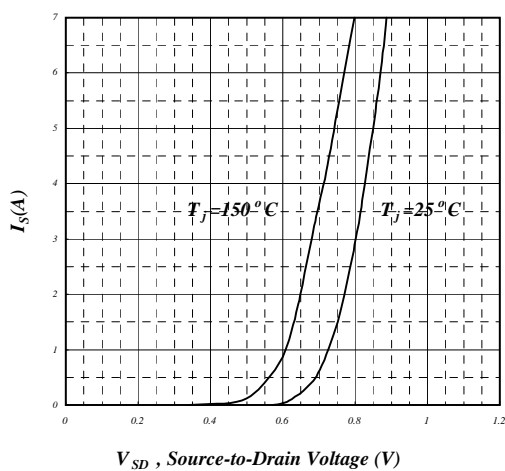


Fig 5. Forward Characteristic of Reverse Diode

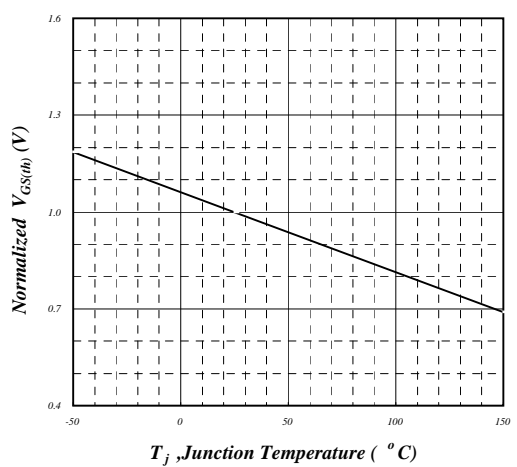


Fig 6. Gate Threshold Voltage v.s. Junction Temperature



Channel-1

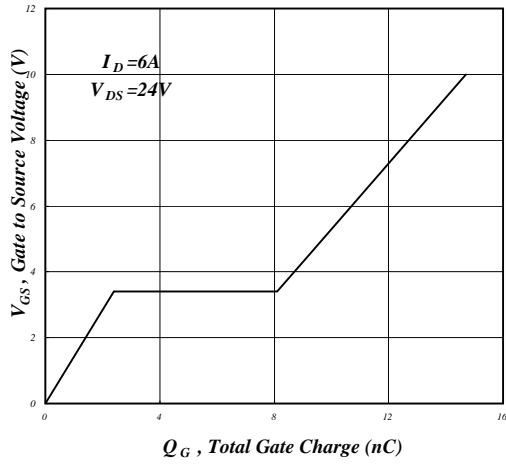


Fig 7. Gate Charge Characteristics

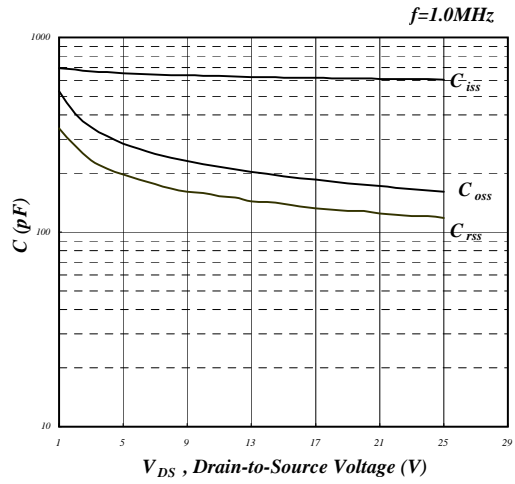


Fig 8. Typical Capacitance Characteristics

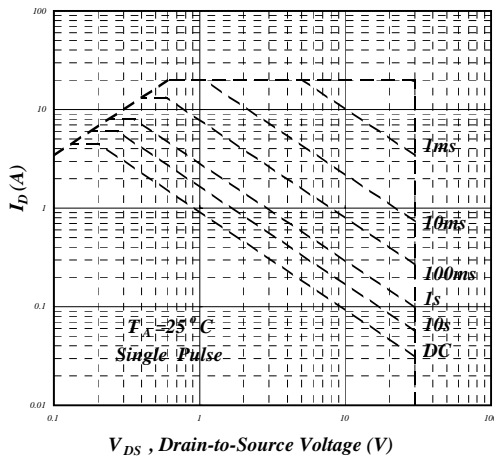


Fig 9. Maximum Safe Operating Area

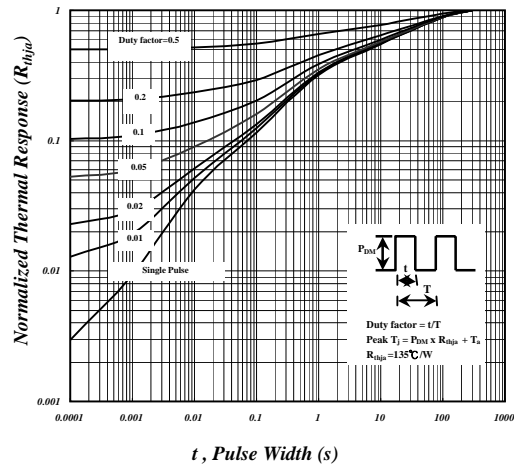


Fig 10. Effective Transient Thermal Impedance

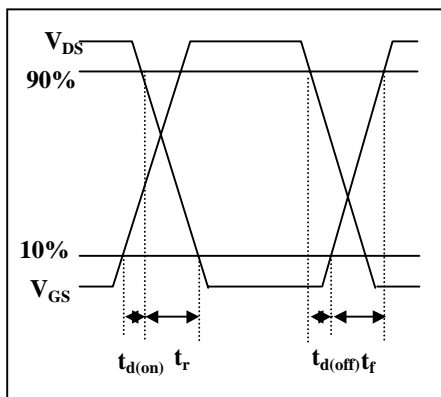


Fig 11. Switching Time Waveform

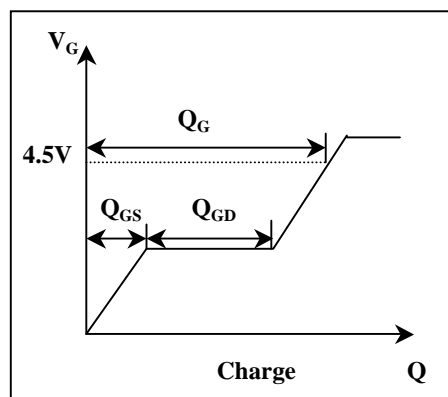


Fig 12. Gate Charge Waveform



AP6900GSM

Channel-2

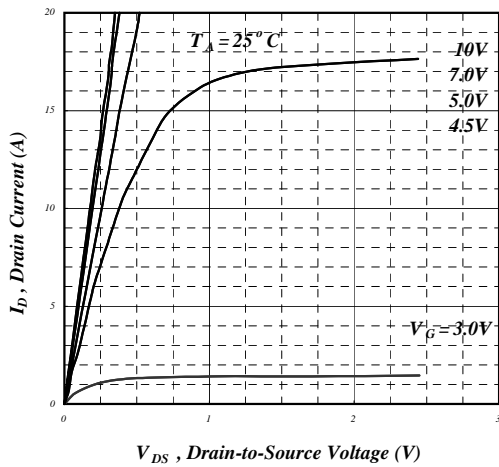


Fig 1. Typical Output Characteristics

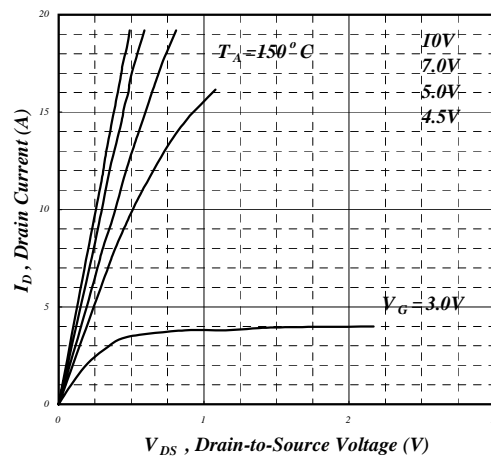


Fig 2. Typical Output Characteristics

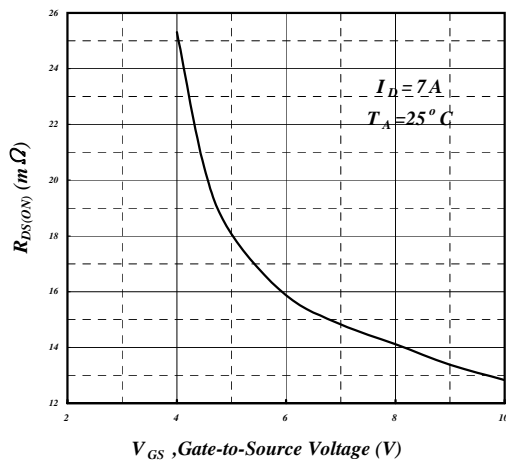


Fig 3. On-Resistance v.s. Gate Voltage

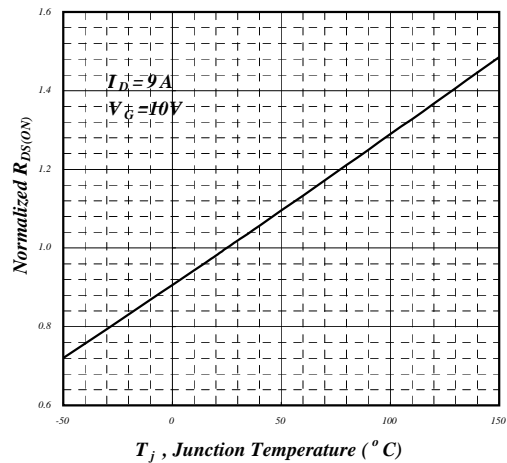


Fig 4. Normalized On-Resistance v.s. Junction Temperature

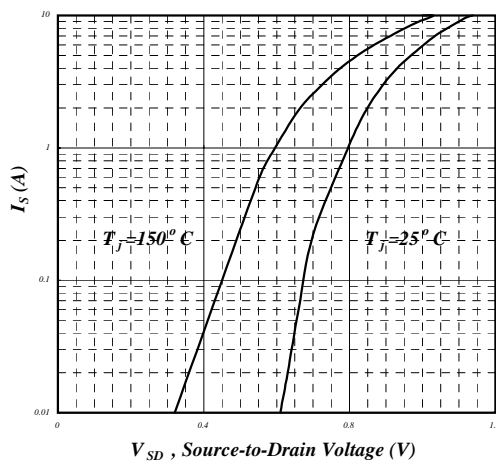


Fig 5. Forward Characteristic of Reverse Diode

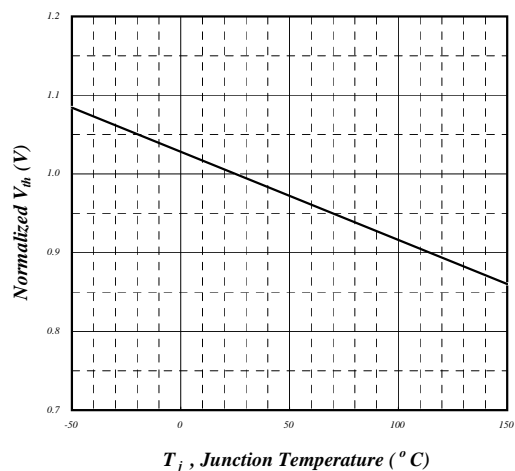


Fig 6. Gate Threshold Voltage v.s. Junction Temperature



Channel-2

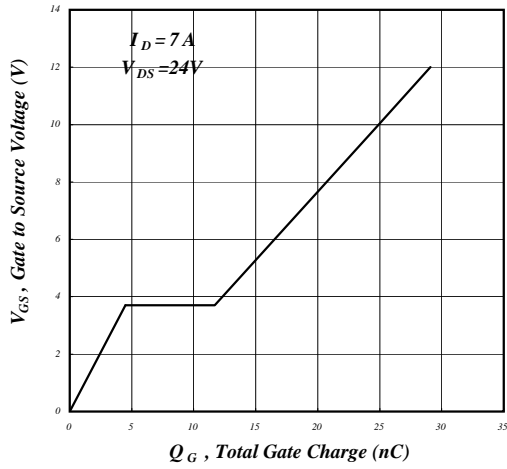


Fig 7. Gate Charge Characteristics

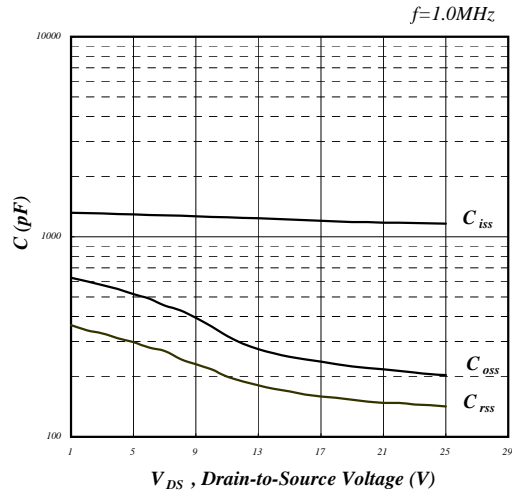


Fig 8. Typical Capacitance Characteristics

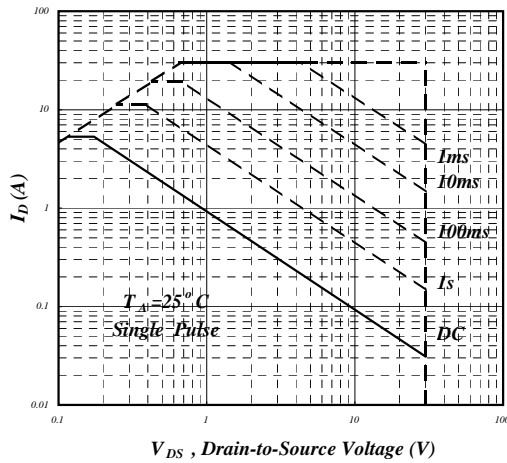


Fig 9. Maximum Safe Operating Area

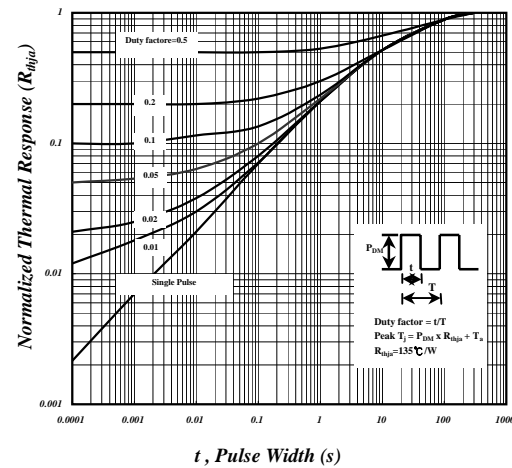


Fig 10. Effective Transient Thermal Impedance

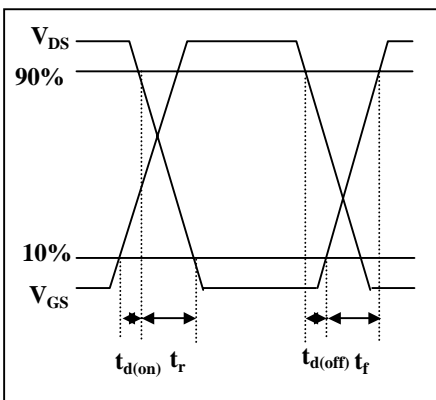


Fig 11. Switching Time Waveform

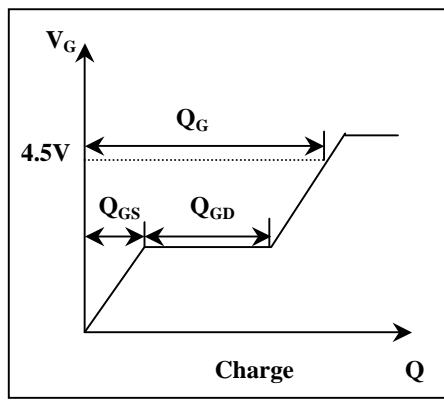


Fig 12. Gate Charge Waveform



Schottky

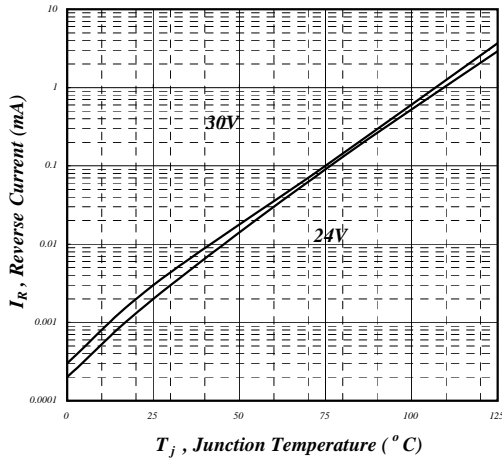


Fig 1. Reverse Current vs Junction Temperature

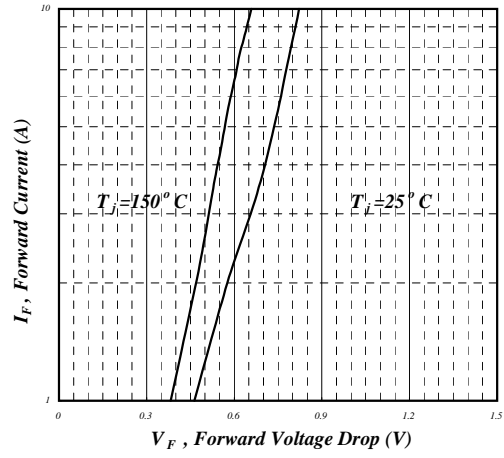


Fig 2. Typical Forward Characteristics

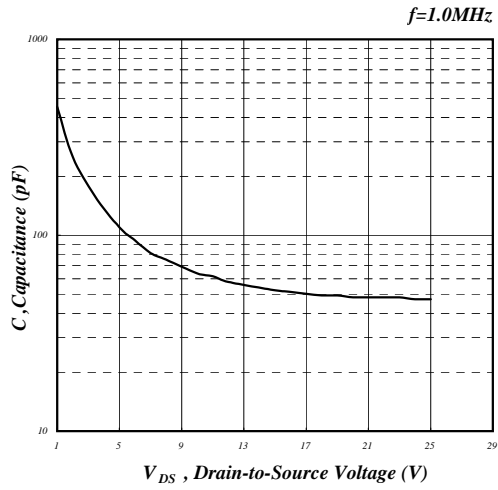


Fig 3. Typical Junction Capacitance